

CHARM PHYSICS at TAU-CHARM FACTORY

Peter Kim
SLAC

Absolute Measurement of D Branching Ratios

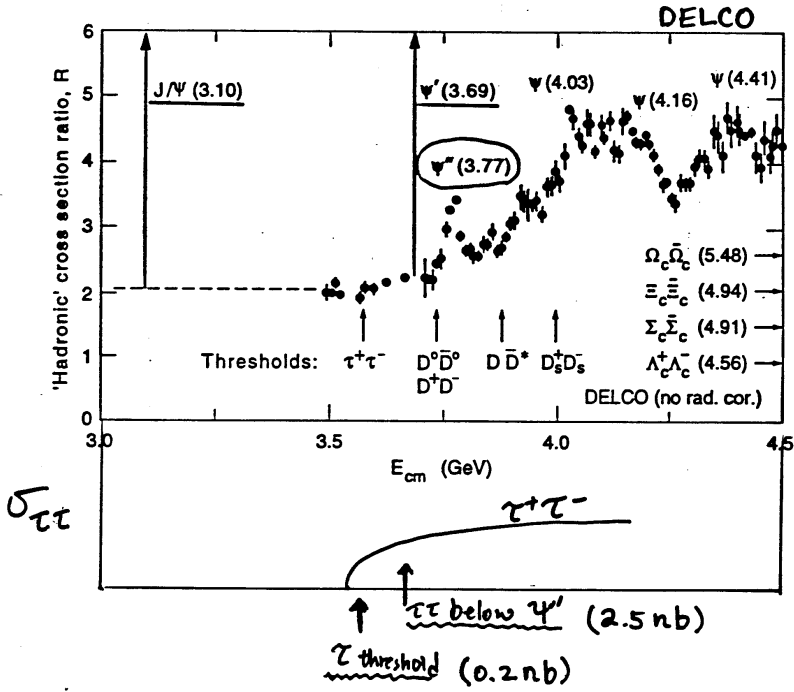
DD-bar Mixing & CP Violation → T. Liu's Talk

Leptonic Decays: $D \rightarrow l \nu$

Rare Charm Decays

Tau-Charm Physics Workshop
SLAC, Mar 6-9, 1999

e^+e^- CROSS SECTIONS NEAR 4 GeV



$\psi'' (3770) \sim 10 \text{ nb}$ cross section

$\rightarrow D^0 \bar{D}^0$ (5.3 nb)

$\rightarrow D^+ D^-$ (4.7 nb)

1 year at $1 \times 10^{33} \text{ cm}^{-2} \text{ s}^{-1}$

5.3×10^7 Events

4.7×10^7 Events

(200 million u.d.s continuum Background Events...)

D Meson Reconstruction at ψ''

$E_{\text{beam}} = E_D \Rightarrow$ Beam-constrained mass

$$M = \sqrt{E_{\text{beam}} - |\sum P_i|^2}$$

$$E_{\text{beam}} - \sum E_i = 0$$

$D^0 \rightarrow$	BR	# Detected/yr
$K^- \pi^+$	0.042	2.7×10^6
$\bar{K}^0 \pi^0$	0.020	2.1×10^5
$\bar{K}^0 \pi^+ \pi^-$	0.064	9.4×10^5
$K^- \pi^+ \pi^0$	0.130	3.0×10^6
$K^- \pi^+ \pi^+ \pi^-$	0.091	3.3×10^6
$\bar{K}^0 \phi$	0.010	3.1×10^4
$\pi^+ \pi^-$	0.002	1.6×10^5
$K^+ K^-$	0.005	2.5×10^5
$K^- \pi^+ \pi^0 \pi^0$	0.149	1.2×10^6
Total		1.2×10^7
$D^+ \rightarrow$		
$\bar{K}^0 \pi^+$.0320	4.1×10^5
$K^- \pi^+ \pi^+$	0.091	3.6×10^6
$\bar{K}^0 \pi^+ \pi^0$	0.130	5.9×10^5
$\bar{K}^0 \pi^+ \pi^- \pi^+$	0.066	3.5×10^5
$K^+ K^- \pi^+$	0.011	3.5×10^5
$\bar{K}^0 K$	0.010	1.1×10^5
$K^- \pi^+ \pi^+ \pi^- \pi^+$	0.007	4.2×10^4
Total		5.5×10^6
$D_s \rightarrow$		
$\phi \pi$	0.030	1.1×10^5
$S^* \pi$	0.009	1.0×10^5
$\bar{K}^0 K^+$	0.030	1.7×10^5
$\eta \pi^+$	0.080	3.4×10^5
$K^{*0} K^+$	0.030	1.1×10^5
Total		8.3×10^5

$\sigma(M_D \text{ beam-constr.}) = 0.6 \text{ MeV}$

$$D^+ \rightarrow \ell \nu X = 17\% \times 2 !$$

(Semileptonic tags?)

$$\psi(4.03) \rightarrow D_s^+ D_s^-$$

$$\rightarrow D \bar{D}^{(*)}$$

BASELINE TCF DETECTOR PERFORMANCE

Jasper Kirkby
 CERN
 5 January 1999

Table 1: Baseline performance of a generic τ CF detector, based on current BF detectors and previous τ CF studies. The symbol ' \oplus ' denotes addition in quadrature.

Item	Baseline τ CF detector performance
Charged particles:	
Momentum resolution: $\sigma_p/p(\text{GeV}/c)$	$0.2\%p \oplus 0.2\%/\beta$
Angular resolution: $\sigma_{\theta,\phi}(\text{mrad})$	$2/p\beta$
$p_t^{\text{min}}(\text{MeV}/c)$ for efficient reconstruction	50
Acceptance	95%
Photons:	
Energy resolution: $\sigma_E/E(\text{GeV})$	$1\%/\sqrt{E} \oplus 2\%$
Angular resolution: $\sigma_{\theta,\phi}(\text{mrad})$	$4/\sqrt{E} \oplus 2$
2γ angular separation (mrad)	50
$E^{\text{min}}(\text{MeV})$ for efficient detection	10
Acceptance	95%
Particle identification (inc. $\bar{C}\bar{e}$):	
K/π separation	$< 10^{-6}$ below 1.5 GeV/c
e/π separation	10^{-4}
μ/π separation	$2\%/p(\text{GeV}/c) + 2\%$
Acceptance	90%
Additional particle identification:	
$p_t^{\text{min}}(\text{MeV}/c)$ for efficient ν tagging by E_{miss}	100
K^0 acceptance \times detection efficiency	80%
μ polarisation acceptance	20%

K_L^0 veto efficiency ?

$$\sigma_{E_{\text{beam}}} = 1.3 \text{ MeV} \Rightarrow \sigma_{\nu} = 1.7 \text{ MeV} \text{ at } E_{\text{beam}} = 2 \text{ GeV}$$

* Charm Deficit in B decays persists ...

* soft π tagging at higher energy: model dependent on Fragmentation model.

We need ABSOLUTE MEASUREMENT with Double-tags.

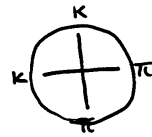
TLF

$N_{D^0 \text{ tag}} : 12 \text{ million}$

$(D^0 \rightarrow K^- \pi^+ \text{ tag} = 2.7 \times 10^6) \leftarrow \text{Limit Systematic Uncertainties}$

Look for 4-prong events

$K^+ \pi^- \leftarrow D^0, D^0 \rightarrow K^- \pi^+$



$\Rightarrow \underline{90,000}$ Reconstructed Events

• SYSTEMATIC ERRORS

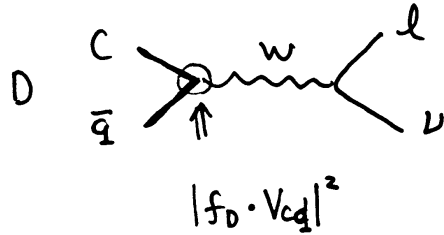
$K^- \pi^+$ reco : 1%/track

tag side : N_{tag} Fit

E_{tag} vs. charge multiplicity

2-3%

LEPTONIC DECAYS



$$f_D^2 \propto \frac{|\psi(0)|^2}{M_D}$$

$$\Gamma(D^+ \rightarrow e^+ \nu) = \frac{G_F^2}{8\pi} f_D^2 \cdot m_D \cdot m_e^2 \cdot |V_{cd}|^2 \cdot \left(1 - \frac{m_e^2}{m_D^2}\right)^2$$

Various Lattice QCD Calculation $\Rightarrow f_D \simeq 220 \text{ MeV}$
 ($\pm 50 \text{ MeV} \dots$)

$$f_B \simeq 130 \text{ MeV}$$

$$f_D = 220 \text{ MeV} \Rightarrow \left\{ \begin{array}{l} \text{Br}(D^+ \rightarrow \tau \nu) = 1.0 \times 10^{-3} \\ \text{Br}(D^+ \rightarrow \mu \nu) = 4 \times 10^{-4} \\ \text{Br}(D_s \rightarrow \tau \nu) = 5 \times 10^{-2} \\ \text{Br}(D_s \rightarrow \mu \nu) = 5 \times 10^{-3} \end{array} \right.$$

<u>Exp.</u>	<u>MODE</u>	<u>N_{evt}</u>	<u>f_{D_s}</u>
WA 75	$\mu\nu$	6	$282 \pm 30 \pm 43 \pm 34$
E 653	$\mu\nu$	$23 \pm 6 \pm 1$	$190 \pm 34 \pm 20 \pm 26$
BES	$\mu\nu$	3	$430 \pm \frac{150}{140} \pm 40$
CLEO	$\mu\nu$	182 ± 22	$280 \pm 19 \pm \underline{28} \pm 34$
DELPHI	$\tau\nu$	10.8 ± 5.4	~ 330
L3	$\tau\nu$	15.6 ± 6.0	$309 \pm 58 \pm 33 \pm 38$

CLEO \rightarrow B-factory : Systematic errors will
Dominate

E653

emulsion target

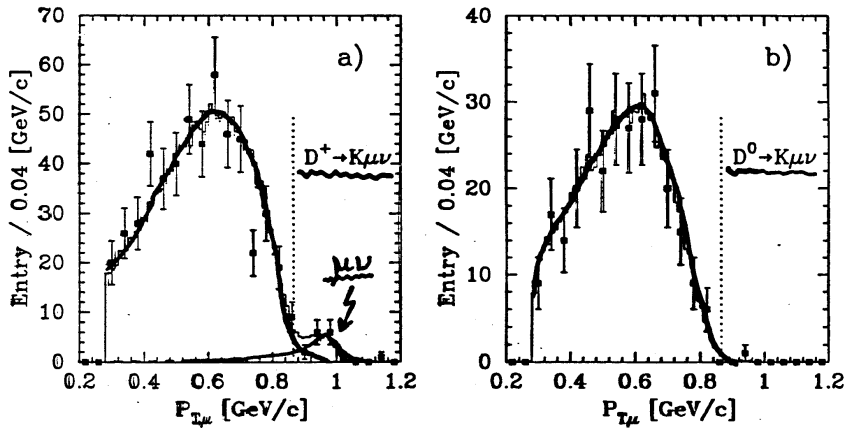
600 GeV/c π^- beam

μ trigger $\rightarrow 8.2 \times 10^6$ events ($P_{T\mu} > 800 \text{ MeV}$)

Vertexing in Silicon Strip Detector & Emulsion

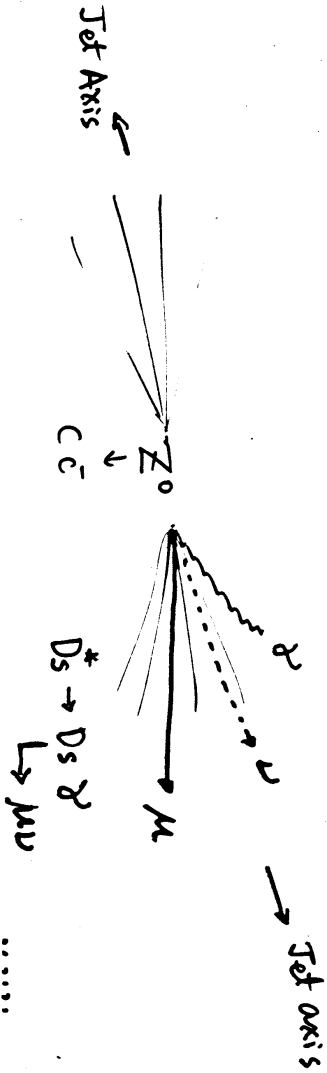
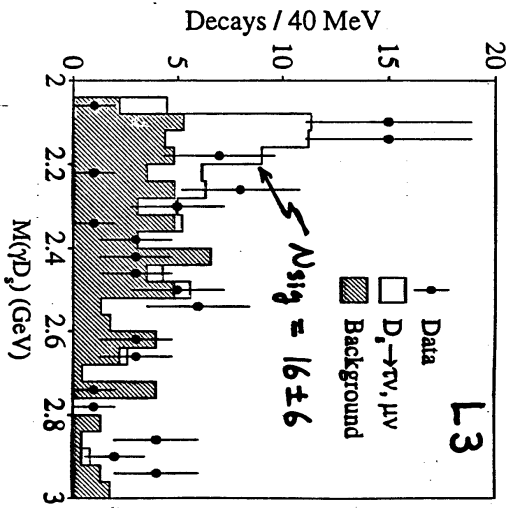
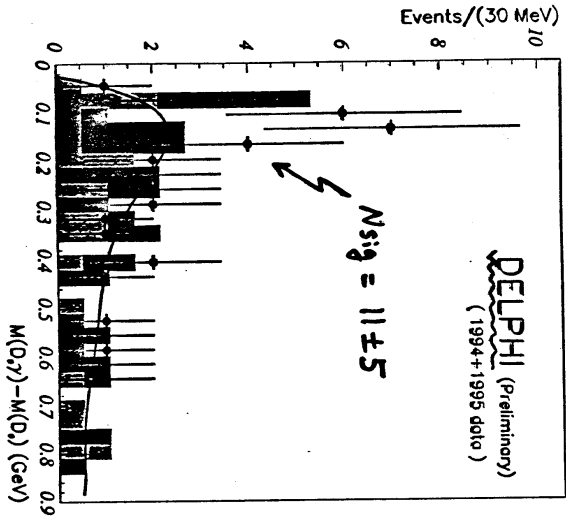
{ 531 KINK (1-prong)
276 V (2-prong)

Muon P_t relative to BEAM AXIS



$$N_{\text{ext}} = 23 \pm 6 \pm 1$$

$$\text{Normalize to } \phi_{\mu\nu} \Rightarrow f_{D_s} = 190 \pm 34 \pm 20 \pm 26 \text{ MeV}$$



$D_s \rightarrow \mu \nu$ Analysis at CLEO

$$D_s^* \rightarrow D_s \gamma \\ \quad \quad \quad \hookrightarrow \mu \nu$$

- neutrino reconstruction Technique

$$\begin{cases} E_\nu = E_{cm} - E_{obs.} \\ \vec{P}_\nu = -\sum_i \vec{P}_{obs. i} \end{cases}$$

Hermiticity of CLEO detector Crucial!

- Determine \vec{P}_{D_s} using $\vec{P}_\mu = \vec{P}_\nu$
- Look for $D_s^* \rightarrow D_s \gamma$ signal.

Small Q^2 in $D_s^* \rightarrow D_s \gamma$

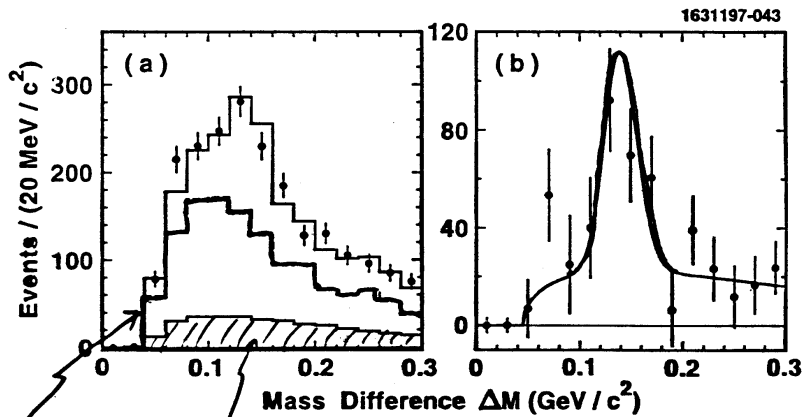
\Rightarrow Poor measurement of \vec{P}_{D_s} does not degrade $\Delta m = D_s^* - D_s$ mass diff. too much.

Largest Source of Background

$D \rightarrow \underline{X} \ell \nu$ Semileptonic Decays

$X \in \{e, \mu\}$] Same size contributions

(within ϵ difference
fake rate diff.)



$D_s \rightarrow e \nu$
Analysis
(normalized)

μ/e fake rate
difference

$N_{sig.} = 182 \pm 22$

Systematic errors in $D_s \rightarrow \mu \nu$ (CLEO)

TABLE II. Systematic Errors on Width Ratio (%)

Source of Error	Value	Size of error (%)
ID { Muon fake rate	$(0.69 \pm 0.05)\%$	9
Electron fake rate	$(0.21 \pm 0.03)\%$	7
$\pi/K/p$ fractions (sources of fakes)	67%/20%/13%	7
• μ/e normalization	1.01 ± 0.03	9
• Detection efficiency	$(4.2 \pm 0.3)\%$	7
✓ D_s^+ / D_s^+ production ratio	1.08 ± 0.13	8
✓ $\phi \pi^+$ normalization	$24740 \pm 1200 \pm 810$	3
Total systematic error		20

B-Factory 10-15% ? poor Hermiticity at Asymmetric B-factory

TCF

$\left\{ \begin{array}{l} N_{\text{evt}} = 300 \Rightarrow 6\% \\ \text{Systematic error similar to } K\pi \text{ absolute meas.} \\ \sim 3\% \end{array} \right.$

\Rightarrow 3% uncertainty in f_D

D⁺ → μ⁺ν Analysis at TCF

- USE 5.5 × 10⁶ D[±] tag sample.

⇒ \vec{P}_{D^+} direction

- PLOT |Missing Mass|² = (E_{CM} - E_D - E_μ)² - P_{obs}²

⇒ narrow peak at zero.

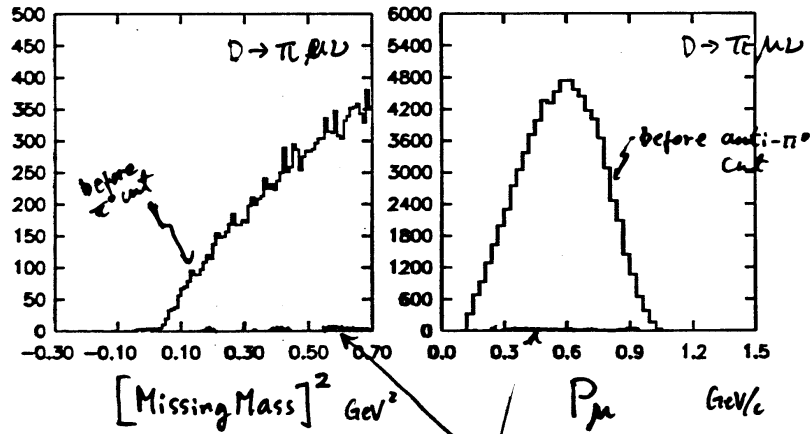
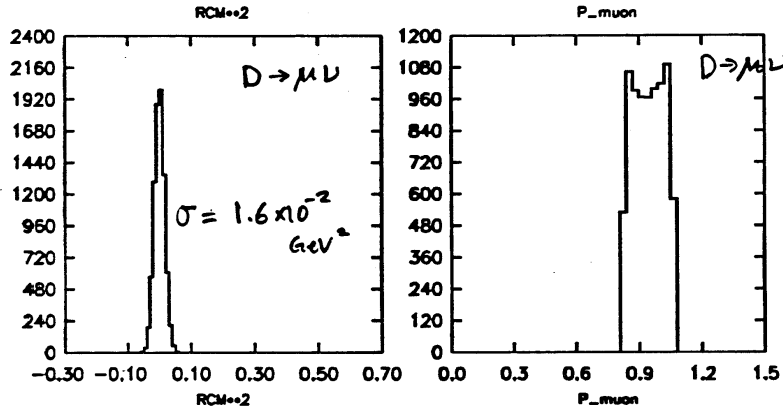
- NO extra tracks or showers

Simple Detector Simulation

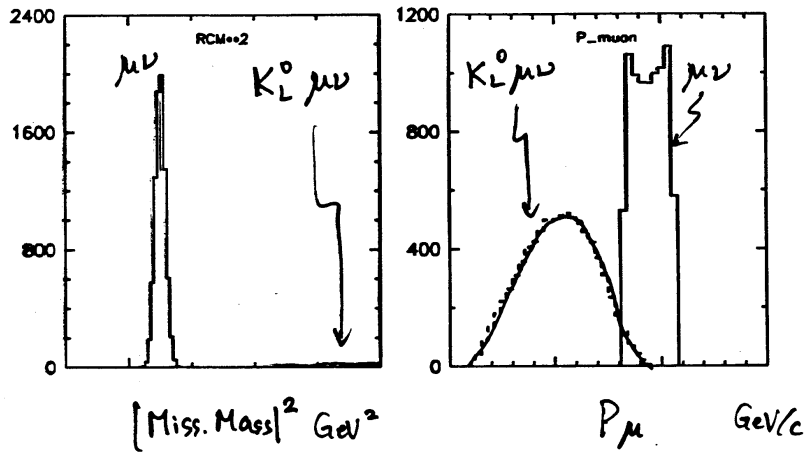
Sources of Background

$$\begin{cases} K_L^0 \mu \nu & \text{B.R.} = 3.5 \times 10^{-2} \\ \pi^0 \mu \nu & \text{B.R.} = 3 \times 10^{-3} \end{cases}$$

$$\begin{cases} K_L^0 \underline{\pi}^+ \\ \pi^0 \underline{\pi}^+ \end{cases} \quad \begin{array}{l} 4\% \mu/\pi \text{ misid at } 1 \text{ GeV}/c \\ (90\% \text{ efficiency}) \end{array}$$



Very low level
of background
from $\pi^0 \mu \nu$



K_L^0 veto : assumed 98%

$N_{sig} = 300 \Rightarrow Br(D \rightarrow \mu\nu)$ at 6% uncertainty
(Statistical)

* Tried $D^- \rightarrow \bar{K}^+ l \nu$ tag vs. $D^+ \rightarrow \mu \nu$

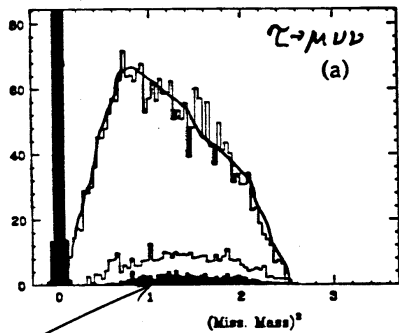
No missing mass peak $\Rightarrow P_\mu$ measurement

TCF

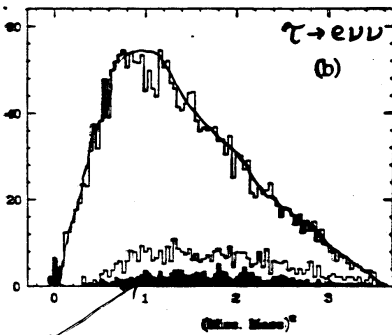
$D_s \rightarrow \tau \nu$
 $\hookrightarrow e \nu \nu, \mu \nu \nu$

- e, μ ID at Low momentum
- No simple signal peak
 \Rightarrow require accurate background estimate

K_L^0 VETO!!!



$D_s^+ \rightarrow K_L^0 \mu \nu$
dominant Background



$D_s^+ \rightarrow K_L^0 e \nu$

$O(2000)$ signal events

Large Sys. errors

$D_s \rightarrow \mu \nu / D_s \rightarrow \tau \nu$ Ratio

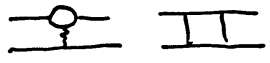
(5-10)% accuracy
Sensitive to New Physics

1 year running at
4.03 GeV

Probably Not

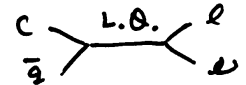
$D_s^+ \rightarrow \tau^+ \nu$ very difficult
(1/10 signal, $\times 10$ background)

RARE CHARM DECAYS

LOOPS/Box $< 10^{-8}$ in SM 

INDIRECT SEARCH FOR NEW PHYSICS

New particles in the loop

New couplings e.g. 

RARE B Decays

mass-dep. couplings favor b quark

Limits comparable to Rare D...

$B \rightarrow \mu\mu X$ vs. $D \rightarrow \mu\mu X$

$N_B = 30 \times 10^6$ at B-factory
(1 year; 3×10^{13})

RARE K Decays

Limits approaching $10^{-10} - 10^{-11}$

KTeV

$K^+ \rightarrow \pi^+ \nu \bar{\nu}$

PRECISION MEAS. at the Z^0

\Downarrow Window of opportunity in charm sector getting smaller

Experimental Limits

- $D \rightarrow$ Charged final states with Leptons

e.g. $D \rightarrow K\mu\mu, e\mu\mu, \dots$
 $\rightarrow \mu\mu X$

SELEX
 FOCUS
 CDF/DØ
 BTeV

- $D \rightarrow$ final states with neutrals

$D \rightarrow \pi^+ \nu\nu, K\nu\nu$

{New physics} $\rightarrow K\nu\nu$

$\Rightarrow K\ell\ell$ limit more strict !!!

- Radiative D decays

$D \rightarrow K^* \gamma, \rho \gamma$ $< \text{few} \times 10^{-4}$ CLEO

Long Dist
 effect
 at 10^{-5} level
 (J. Hewlett)

B-Factor: merged π^0
 Combinatorial BkgD

ICF { 10^{-5} level with Tag sample
 10^{-6} ? no tag

$D \rightarrow \gamma$ "nothing"

(unknown background level)
 \uparrow better understanding of $g\bar{g}$
 cont

Conclusion

1 year Running at $\Psi''(3770)$

$$\mathcal{L} = 1 \times 10^{33} \text{ cm}^{-2} \text{ s}^{-1}$$

\Rightarrow ABSOLUTE D BRANCHING RATIO : $\sim 3\%$ meas.
(systematically Limited)

\Rightarrow f_D measurement : 3% uncertainty
(statistically Limited)

$D\bar{D}$ mixing / CP violation search

complementary to B-factories/hadronic Radi

Look for $\Psi'' \rightarrow$ CP-odd configuration of
 $(K^+K^-)(\pi^+\pi^-)$ CP-odd state

Rare Decays

Radiative Decays ($D \rightarrow \gamma X$) at 10^{-5} level

New physics will be of "unexpected" type.